

RoHS

COMPLIANT HALOGEN

FREE

AFN4210S8RG-VB Datasheet Dual N-Channel 30-V (D-S) MOSFET

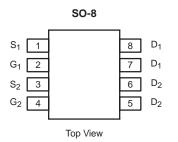
| PRODUCT SUMMARY | | | | | | |
|---------------------|----------------------------------|--------------------|-----------------------|--|--|--|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) | Q _g (Typ.) | | | |
| 30 | 0.022 at V_{GS} = 10 V | 6.8 | 15 nC | | | |
| | 0.026 at V _{GS} = 4.5 V | 6.0 | 15110 | | | |

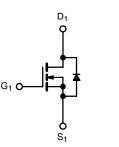
FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- Trench Power MOSFET
- 100 % UIS Tested
- 100 % Rg Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Set Top Box
- Low Current DC/DC







N-Channel MOSFET

N-Channel MOSFET

| ABSOLUTE MAXIMUM RATIN | | | Limit | l lm:t | |
|---|------------------------|-----------------------------------|----------------------|--------|--|
| Parameter | | Symbol | | Unit | |
| Drain-Source Voltage | | V _{DS} | 30 | V | |
| Gate-Source Voltage | | V _{GS} | ± 20 | V | |
| | T _C = 25 °C | | 6.8 ^a | | |
| Continuous Drain Current (T _{.1} = 150 °C) | T _C = 70 °C |] I_ | 5.6 | | |
| Continuous Drain Guirent (1j = 150°C) | T _A = 25 °C | I _D | 6.2 ^{b, c} | | |
| | T _A = 70 °C | | 5.2 ^{b, c} | A | |
| Pulsed Drain Current | | I _{DM} | 30 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | - I _S | 2.25 | | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | | 1.48 ^{b, c} | | |
| Single Pulse Avalanche Current | L = 0.1 mH | I _{AS} | 5 | | |
| Single Pulse Avalanche Energy | | E _{AS} | 1.25 | mJ | |
| | T _C = 25 °C | | 2.7 | | |
| Maximum Dawar Disaination | T _C = 70 °C | – P _D | 1.77 | w | |
| Maximum Power Dissipation | T _A = 25 °C | | 1.78 ^{b, c} | VV | |
| | T _A = 70 °C | | 1.14 ^{b, c} | | |
| Operating Junction and Storage Temperatur | e Range | T _J , T _{stg} | - 55 to 150 | °C | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|--|--------------|-------------------|---------|------|------|--|
| Parameter | Symbol | Typical | Maximum | Unit | | |
| Maximum Junction-to-Ambient ^{a, c, d} | t ≤ 10 s | R _{thJA} | 58 | 70 | °C/W | |
| Maximum Junction-to-Foot (Drain) | Steady State | R _{thJF} | 38 | 45 | 0/11 | |

Notes:

a. Package limited, $T_C = 25 \ ^{\circ}C$.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 110 °C/W.

| $\begin{array}{ c c c c c c } \hline Parameter & Symbol & Test Conditions & Min. Typ. Max. Unit Static & V_{DS} & V_{OS} = 0 \ V, \ I_D = 250 \ \mu A & 30 & V & V_{OS} & V_{OS} = 0 \ V, \ I_D = 250 \ \mu A & 30 & -5.0 & V_{OS} & V_{OS} & V_{OS} = 0 \ V, \ I_D = 250 \ \mu A & -5.0 & V_{OS} & V_{$ | SPECIFICATIONS $T_J = 25 \text{ °C}$, unless otherwise noted | | | | | | | | |
|--|--|-------------------------|---|------|-------|-------|-------|--|--|
| $ \begin{array}{ c c c c c c } \hline Drain-Source Breakdown Voltage & V_{DS} & V_{GS} = 0 V, I_D = 250 \ \mu A & 30 & & & & V \\ V_{DS} temperature Coefficient & \Delta V_{DS} / T_J & I_D = 250 \ \mu A & 1.0 & 2.5 & V \\ \hline M_{CS(th)} & V_{DS} = V_{CS}, I_D = 250 \ \mu A & 1.0 & & 2.5 & V \\ \hline Gate-Source Leakage & I_{CSS} & V_{DS} = 0 V, V_{CS} = 420 V & & \pm 100 & nA \\ \hline Cate-Source Leakage & I_{CSS} & V_{DS} = 0 V, V_{CS} = 20 V & & \pm 100 & \mu A \\ \hline V_{DS} = 30 V, V_{CS} = 0 V & J_{L} = 5 ^{\circ} C & & 10 & \mu A \\ \hline On-State Drain Current & I_{DSS} & V_{DS} = 0 V, V_{CS} = 0 V & 10 & & & \\ \hline On-State Drain Current & I_{DSS} & V_{DS} = 10 V, I_D = 5 A & 0.022 & & \\ \hline On-State Drain Current & I_{DSS} & V_{DS} = 10 V, I_D = 5 A & 16 & & \\ \hline Dynamic^{D} & V_{DS} = 10 V, I_D = 5 A & 16 & & \\ \hline Dynamic^{D} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 16 & & \\ \hline Dupt Capacitance & C_{iss} & & \\ \hline Total Gate Charge & Q_{g} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 15 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 15 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 15 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 16 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 16 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 111 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 114 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 114 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 5 A & 111 & 22 & \\ \hline Fall Time & True & The S & & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 15 V, V_{CS} = 10 V, I_D = 10 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & V_{DS} = 10 V, I_D = 10 V, I_D = 10 & & \\ \hline Turn-On Delay Time & I_{d(ori)} & & \\ \hline Turne & The S & & & \\ \hline Turne & The S & & & \\ \hline Turne & The S & & & \\ \hline Turne & The S & & & \\ \hline Turne & The S & & & \\ \hline Turne & The S & & & \\ \hline Turne & The S &$ | Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Static | | | | | | | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 V, I_D = 250 \mu A$ | 30 | | | V | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | L _ 250 uA | | 32 | | | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = 250 μA | | - 5.0 | | mV/°C | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$ | 1.0 | | 2.5 | V | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 V, V_{GS} = \pm 20 V$ | | | ± 100 | nA | | |
| $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | Zana Orala Malla na Daria Orana at | | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | | | |
| $ \begin{array}{ c c c c c c c } \hline \mbox{Vas} = 10 \ V, \ \mbox{Vas} = 10 \ V, \ \mbox{Vas} = 4.5 \ V, \ \mbox{Vas} = 4.5 \ V, \ \mbox{Vas} = 4.5 \ V, \ \mbox{Vas} = 10 \ $ | Zero Gate Voltage Drain Current | DSS | $V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$ | | | 10 | μA | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$ | 10 | | | А | | |
| Forward Transconductance ^a 9fs $V_{GS} = 4.3$, $V_{ID} = 4$ Å 0.026 I Forward Transconductance ^a 9fs $V_{DS} = 10$ V, $I_{D} = 5$ Å 16 S Dynamic ^b Input Capacitance C_{ISS} $V_{DS} = 10$ V, $I_{D} = 5$ Å 16 S Output Capacitance C_{css} $V_{DS} = 15$ V, $V_{GS} = 0$ V, $f = 1$ MHz 586 I I Total Gate Charge Q_g $V_{DS} = 15$ V, $V_{GS} = 10$ V, $I_D = 5$ Å 155 I | | D | V _{GS} = 10 V, I _D = 5 A | | 0.022 | | Ω | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 4 \text{ A}$ | | 0.026 | | | | |
| $ \begin{array}{ c c c c c c c } \hline Input Capacitance & C_{1SS} \\ \hline Output Capacitance & C_{0SS} \\ \hline Output Capacitance & C_{rSS} \\ \hline \end{tildeliness} \\ \hline \end{tillenss} \\ \hline \end{tildeliness} \\ \hline tillenss$ | Forward Transconductance ^a | 9 _{fs} | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}$ | | 16 | | S | | |
| $ \begin{array}{ c c c c c c } \hline Output Capacitance & C_{oss} & V_{DS} = 15 \ V, \ V_{GS} = 0 \ V, \ f = 1 \ MHz & 117 & 1 & pF \\ \hline \ Reverse \ Transfer \ Capacitance & C_{rss} & V_{DS} = 15 \ V, \ V_{GS} = 10 \ V, \ I_D = 5 \ A & 15 & 1 & 17 & 1 & pF \\ \hline \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$ | Dynamic ^b | | | | | • | • | | |
| $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | Input Capacitance | C _{iss} | | | 586 | | | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Output Capacitance | C _{oss} | V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz | | 117 | | pF | | |
| $ \begin{array}{ c c c c c c c c c c } \hline \mbox{loc} Charge & \mbox{loc} Q_{gs} & & & & & & & & & & & & & & & & & & &$ | Reverse Transfer Capacitance | C _{rss} | | | 55 | | | | |
| $ \begin{array}{ c c c c c c c } \hline \begin{tabular}{ c c c c c } \hline \begin{tabular}{ c c c c c c c } \hline \begin{tabular}{ c c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$ | Total Cata Charge | 0 | V_{DS} = 15 V, V_{GS} = 10 V, I_{D} = 5 A | | 15 | | - nC | | |
| $ \begin{array}{ c c c c c c } \hline Gate-Source Charge & Q_{gs} & V_{DS} = 15 \ V, \ V_{GS} = 4.5 \ V, \ I_D = 5 \ A \\ \hline Gate-Drain Charge & Q_{gd} & 1.4 & 1.$ | Iotal Gale Charge | Q _g | | | 3.7 | 5.6 | | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Gate-Source Charge | Q _{gs} | V_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 5 A | | 1.4 | | | | |
| $ \begin{array}{c c c c c c c c c c } \hline Turn-On Delay Time & t_d(on) \\ \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 3 \ \Omega & 12 & 24 \\ \hline N_{DD} = 15 \ V, \ R_L = 3 \ \Omega & 11 & 22 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega & 11 & 22 \\ \hline Rise Time & t_f & & & & & & & & & & & & & & & & & & &$ | Gate-Drain Charge | Q _{gd} | | | 1.05 | | | | |
| Rise Timetr $V_{DD} = 15 \ V, \ R_L = 3 \ \Omega$ 55100Turn-Off Delay Time $t_{d(off)}$ $I_D \cong 5 \ A, \ V_{GEN} = 4.5 \ V, \ R_g = 1 \ \Omega$ 1122Fall Time t_f 816Turn-On Delay Time $t_{d(on)}$ $V_{DD} = 15 \ V, \ R_L = 3 \ \Omega$ 918Rise Time t_r $V_{DD} = 15 \ V, \ R_L = 3 \ \Omega$ 918Turn-Off Delay Time $t_{d(off)}$ $I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega$ 918Turn-Off Delay Time $t_d(off)$ $I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega$ 91020Fall Time t_f $I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega$ 1020Drain-Source Body Diode Characteristics $T_C = 25 \ ^{\circ}C$ 2.25APulse Diode Forward Current I_S $T_C = 25 \ ^{\circ}C$ 2.25ABody Diode Voltage V_{SD} $I_S = 2 \ A, \ V_{GS} = 0 \ V$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} $I_F = 5 \ A, \ dI/dt = 100 \ A/\mu_S, \ T_I = 25 \ ^{\circ}C$ 48 | Gate Resistance | Rg | f = 1 MHz | 0.8 | 4.3 | 8.6 | Ω | | |
| $\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$ | Turn-On Delay Time | t _{d(on)} | | | 12 | 24 | | | |
| $\begin{tabular}{ c c c c c c } \hline Fall Time & t_f & & & & & & & & & & & & & & & & & & &$ | Rise Time | t _r | | | 55 | 100 | | | |
| $\begin{tabular}{ c c c c c c c } \hline Turn-On Delay Time & t_{d(on)} & t_r & V_{DD} = 15 \ V, \ R_L = 3 \ \Omega & 9 & 18 \\ \hline Rise Time & t_r & V_{DD} = 15 \ V, \ R_L = 3 \ \Omega & 9 & 18 \\ \hline I_D \cong 5 \ A, \ V_{GEN} = 10 \ V, \ R_g = 1 \ \Omega & 10 & 20 \\ \hline Ball Time & t_r & 6 & 12 \\ \hline \hline Drain-Source Body Diode Characteristics & & & & & & & & & & & & & & & & & & &$ | Turn-Off Delay Time | t _{d(off)} | $I_D \cong 5$ A, V_{GEN} = 4.5 V, R_g = 1 Ω | | 11 | 22 | | | |
| $\begin{tabular}{ c c c c c c } \hline Turn-On Delay Time & t_{d(on)} & & & & & & & & & & & & & & & & & & &$ | Fall Time | t _f | | | 8 | 16 | nc | | |
| $ \begin{array}{c c c c c c c c c c c c c c c c c c c $ | Turn-On Delay Time | t _{d(on)} | | | 4 | 8 | 115 | | |
| Fall Time t_f 612Fall Time t_f 612Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode Current I_S $T_C = 25 ^{\circ}C$ 2.25Pulse Diode Forward Current I_SM $I_S = 2 A, V_{GS} = 0 ^{\circ}V$ 0.81.2Body Diode Voltage V_{SD} $I_S = 2 A, V_{GS} = 0 ^{\circ}V$ 0.81.2VBody Diode Reverse Recovery Time t_{rr} $I_F = 5 A, dI/dt = 100 ^{\circ}A/\mus, T_J = 25 ^{\circ}C$ 48nC | Rise Time | t _r | V_{DD} = 15 V, R_L = 3 Ω | | 9 | 18 | | | |
| Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIs $T_C = 25 \text{ °C}$ 2.25APulse Diode Forward CurrentIsm24244Body Diode VoltageVSDIs = 2 A, VGS = 0 V0.81.2VBody Diode Reverse Recovery Time t_{rr} $I_F = 5 A$, dl/dt = 100 A/µs, $T_A = 25 \text{ °C}$ 1120ns | Turn-Off Delay Time | t _{d(off)} | $\text{I}_\text{D}\cong \text{5}$ A, V_GEN = 10 V, R_g = 1 Ω | | 10 | 20 | | | |
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $ | Fall Time | t _f | | | 6 | 12 | | | |
| Pulse Diode Forward CurrentI I SMI SMI SM24ABody Diode VoltageV SDI S FI S SDI S S S S0.81.2VBody Diode Reverse Recovery Timetrr trr1120nsBody Diode Reverse Recovery ChargeQrrI F SI S S S10A | Drain-Source Body Diode Characteristics | | | | | | | | |
| Pulse Diode Forward CurrentI I SMI SM24Body Diode VoltageV SDI S I FI S S S0.81.2V VBody Diode Reverse Recovery Time t_{rr} 1120nsBody Diode Reverse Recovery ChargeQ rrI I F5 A, dl/dt = 100 A/µs, T, I = 25 °C48nc | Continuous Source-Drain Diode Current | ۱ _S | T _C = 25 °C | | | 2.25 | Δ | | |
| Body Diode Reverse Recovery Time t_{rr} 11 20 ns Body Diode Reverse Recovery Charge Q_{rr} $I_F = 5 \text{ A}$, $dI/dt = 100 \text{ A/µs}$, $T_I = 25 \text{ °C}$ 4 8 nC | Pulse Diode Forward Current | | | | | 24 | 7 | | |
| Body Diode Reverse Recovery Charge Q_{rr} $I_F = 5 A$, $dI/dt = 100 A/\mu s$, $T_J = 25 °C$ 4 8 nC | Body Diode Voltage | V _{SD} | $I_{S} = 2 \text{ A}, V_{GS} = 0 \text{ V}$ | | 0.8 | 1.2 | V | | |
| $I_{\rm F} = 5$ A, dl/dt = 100 A/µs, $I_{-1} = 25$ °C | Body Diode Reverse Recovery Time | t _{rr} | | | 11 | 20 | ns | | |
| | Body Diode Reverse Recovery Charge | Q _{rr} | l= = 5 A dl/dt = 100 Δ/με Τ. = 25 °C | | 4 | 8 | nC | | |
| | Reverse Recovery Fall Time | t _a | $r_{\rm F} = 0.7$, and $= 100.7$ (μ s, $r_{\rm J} = 20.0$ | | 7 | | | | |
| Reverse Recovery Rise Time tb | Reverse Recovery Rise Time | t _b | | | 4 | | ns | | |

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

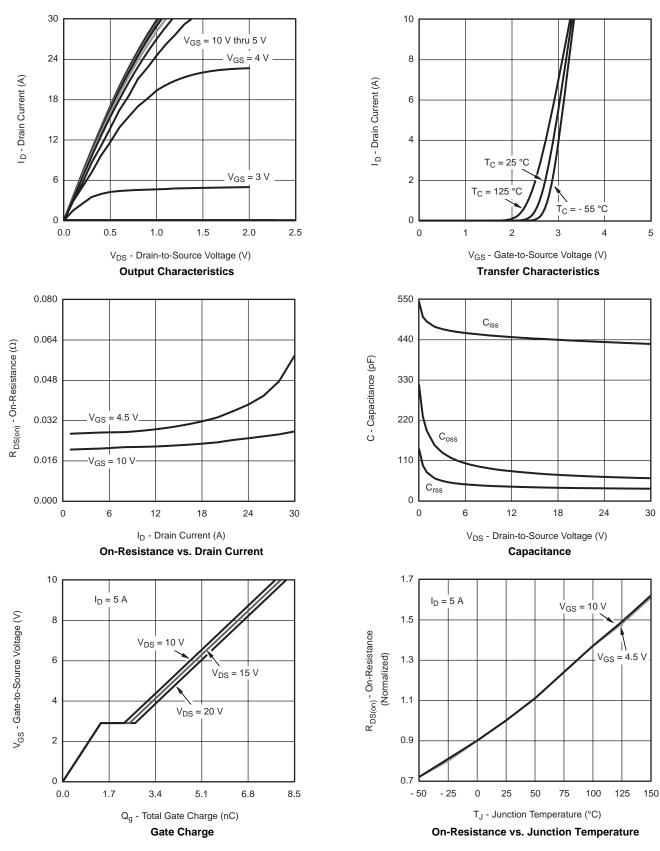
semi

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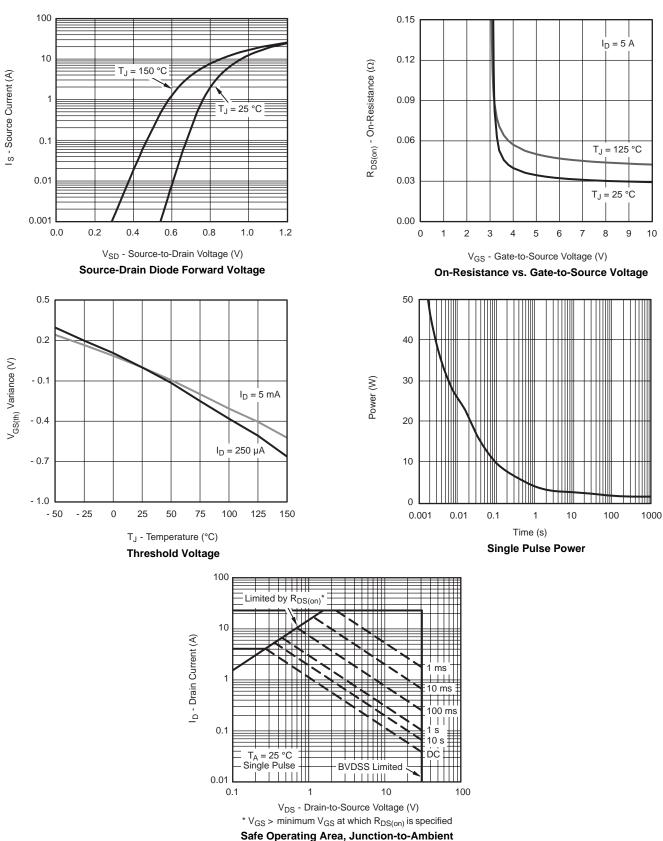
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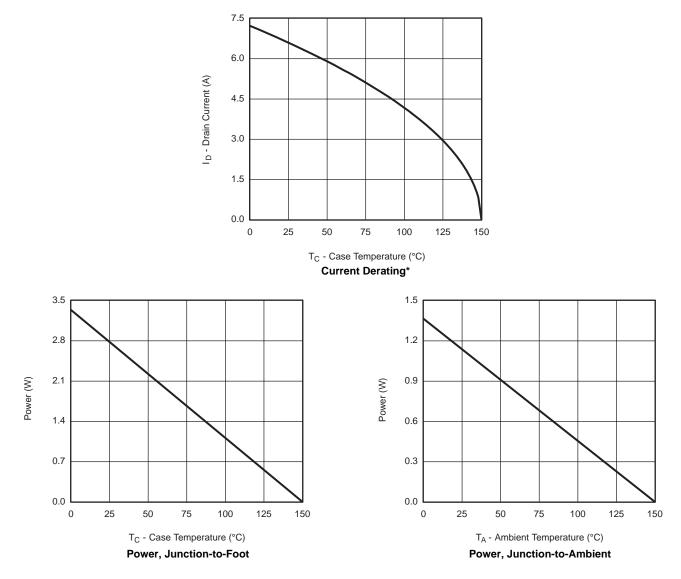








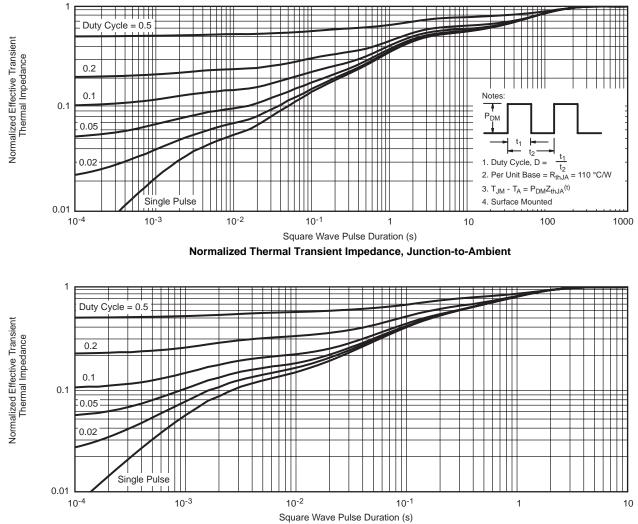
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



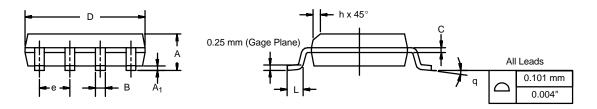
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

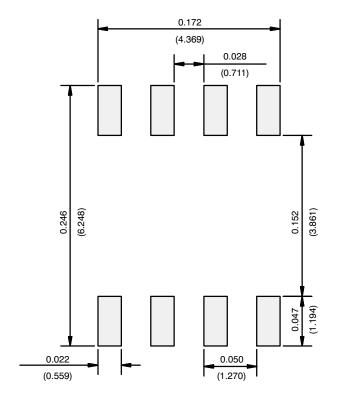




| | MILLIMETERS | | INC | HES | | |
|---|-------------|------|--------|-------|--|--|
| DIM | Min | Max | Min | Max | | |
| A | 1.35 | 1.75 | 0.053 | 0.069 | | |
| A ₁ | 0.10 | 0.20 | 0.004 | 0.008 | | |
| В | 0.35 | 0.51 | 0.014 | 0.020 | | |
| С | 0.19 | 0.25 | 0.0075 | 0.010 | | |
| D | 4.80 | 5.00 | 0.189 | 0.196 | | |
| E | 3.80 | 4.00 | 0.150 | 0.157 | | |
| е | 1.27 | BSC | 0.050 |) BSC | | |
| н | 5.80 | 6.20 | 0.228 | 0.244 | | |
| h | 0.25 | 0.50 | 0.010 | 0.020 | | |
| L | 0.50 | 0.93 | 0.020 | 0.037 | | |
| q | 0° | 8° | 0° | 8° | | |
| S | 0.44 | 0.64 | 0.018 | 0.026 | | |
| ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498 | | | | | | |



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



Disclaimer

All products due to improve reliability, function or design or for other reasons, product specifications and data are subject to change without notice.

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